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TITLE: "C-SCE AND METHOD TO REDUCE WORDLINE TIME CONSTANT
IN SEMICONDUCTOR MEMORY DEVICES"
INVENTORS NAME: Huy Thanh Vo
SERIAL NO.: 09/808,750

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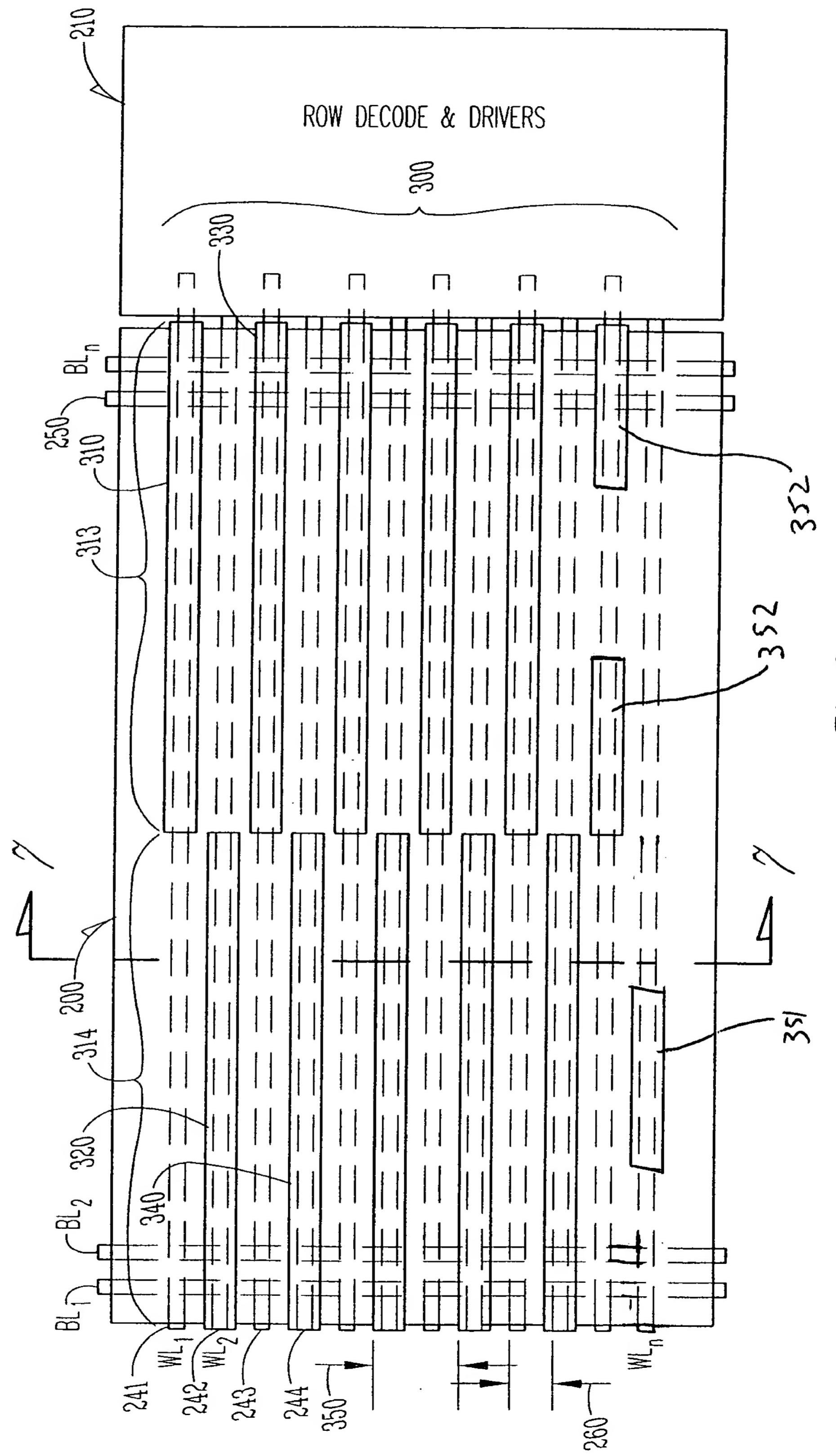


Fig. 6